

**INFORMATION DISCLOSURE STATEMENT**  
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980.1122US01Serial Number  
10/015151Applicant(s)  
HedinFiling Date  
December 11, 2001Group Art Unit  
2881**U.S. PATENT DOCUMENTS**

EXAMINER INITIALS	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE (IF APPROPRIATE)
PCW		4,896,325	01/23/90	Coldren			
		5,167,444	12/01/92	Hall			
		5,323,409	06/21/94	Laskoskie et al.			
		5,428,700	06/27/95	Hall			
		5,621,828	04/15/97	Baets et al.			
		5,715,265	02/03/98	Epworth			
		5,798,859	08/25/98	Colbourne et al.			
		5,825,792	10/20/98	Villeneuve et al.			
		5,828,689	10/27/98	Epworth			
		5,943,152	08/24/99	Mizrahi et al.			
		5,956,356	09/21/99	Bergmann et al.			
		5,963,686	10/05/99	Zheng et al.			
		6,064,681	05/16/00	Ackerman			
		6,067,181	05/23/00	Mizrahi			
		6,094,271	07/25/00	Maeda			
		6,111,681	08/29/00	Mizrahi et al.			
		6,122,301	09/19/00	Tei et al.			
		6,125,128	09/26/00	Mizrahi			
		6,212,210	04/03/01	Serizawa			
		6,233,263	05/15/01	Chang-Hasnain et al.			
		6,243,403	06/05/01	Broutin et al.			
		6,272,157	08/07/01	Broutin et al.			
		2001/0007501 A1	07/12/01	Frojd			

**FOREIGN PATENT DOCUMENTS**

EXAMINER INITIALS	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION	
							YES	NO

**OTHER DOCUMENTS**

PCW		M. Oberg et al., "74 nm Wavelength Tuning Range of an InGaAsP Vertical Grating Assisted Codirectional Coupler Laser with Rear Sampled Grating Reflector," <i>IEEE Photonics Technology Letters</i> , 5(7):735-738 (July 1993).
		P.J. Rigole et al., "114-nm Wavelength Tuning Range of a Vertical Grating Assisted Codirectional Coupler Laser with a Super Structure Grating Distributed Bragg Reflector," <i>IEEE Photonics Technology Letters</i> , 7(7):697-699 (July 1995).
		Derickson, "Static Fizeau Interferometer Wavelength Meter", <i>Fiber Optic Test and Measurement</i> , Prentice-Hall, ISBN 0-13-534330-5, 163-165 (1998).
		U.S. Application Serial No. 09/871,230, filed May 31, 2001.
		U.S. Application Serial No. 10/014,218, filed October 22, 2001.
		U.S. Application Serial No. 10/014,278, filed December 11, 2001.
		U.S. Application Serial No. 10/014,277, filed December 11, 2001.

Examiner:

PCW

Date Considered:

3/11/02

